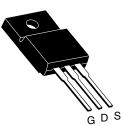
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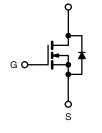


E Series Power MOSFET

PRODUCT SUMMA	RY	
V _{DS} (V) at T _J max.	650)
R _{DS(on)} max. at 25 °C (Ω)	$V_{GS} = 10 V$	0.125
Q _g max. (nC)	130)
Q _{gs} (nC)	15	
Q _{gd} (nC)	39	
Configuration	Sing	le

TO-220 FULLPAK





N-Channel MOSFET

FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
 - LED lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
- · Battery chargers
- Renewable energy
 - Solar (PV inverters)

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free and Halogen-free	SiHF30N60E-GE3
Lead (Pb)-free	SiHF30N60E-E3

ABSOLUTE MAXIMUM RATINGS (T _C :	= 25 °C, unle	ss otherwis	se noted)			
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	600	V		
Gate-Source Voltage			V _{GS}	± 30	- V	
Continuous Drain Current (T ₁ = 150 °C) ^d	V _{GS} at 10 V	T _C = 25 °C		29		
Continuous Drain Current $(1_j = 150 \text{ C})^2$	V _{GS} at 10 V	T _C = 100 °C	ID	18	A	
Pulsed Drain Current ^a			I _{DM}	76		
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	690	mJ	
Maximum Power Dissipation			P _D	37	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	V _{DS} = 0 V to	80 % V _{DS}	-1) / / -1+	70		
Reverse Diode dV/dt ^e	•		dV/dt	18	V/ns	
Soldering Recommendations (Peak temperature) ^c	for 10)s		300	°C	
Mounting Torque	M3 sc	rew		0.6	Nm	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 28.2 mH, $R_q = 25 \Omega$, $I_{AS} = 7$ A.

c. 1.6 mm from case.

d. Limited by maximum junction temperature.

e. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C.

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COMPLIANT HALOGEN

FREE



Vishay Siliconix

$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	THERMAL RESISTANCE RATI	NGS							
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Maximum Junction-to-Ambient	R _{thJA}	-		65			°C ///	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	Maximum Junction-to-Case (Drain)	R _{thJC}	-		3.4			-0/w	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$									
Static V _{DS} V _{DS} = 0 V, I _D = 250 µA 600 - - V Orain-Source Dreakdown Voltage Δ V _{DS} /T _J Reference to 25 °C, I _D = 250 µA - 0.64 - V/r Gate-Source Threshold Voltage (N) V _{GS} (m) V _{DS} = 250 µA 2.0 2.8 4.0 V/r Gate-Source Leakage I _{GSS} V _{GS} = ±20 V - - ± 100 nA Zero Gate Voltage Drain Current I _{DSS} V _{DS} = 600 V, V _{GS} = 0 V - - 100 µA Drain-Source On-State Resistance R _{DS(m)} V _{SS} = 10 V I _D = 15 A - 0.104 0.125 Ω Porward Transconductance [®] g ₁₆ V _{DS} = 0 V, V _{DS} = 10 V - 138 - Input Capacitance C _{ress} V _{DS} = 10 V, V _{DS} = 0 V, V _D									
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		SYMBOL	IES	I CONDII	IONS	MIN.	TYP.	MAX.	UNI
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			T			1		[
						600		-	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$				-	0.64	-	V/°C
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage (N)	V _{GS(th)}	-			2.0	2.8	4.0	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Leakage	loss				-	-	± 100	nA
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		1655		$V_{GS} = \pm 30$	V	-	-	± 1	μA
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Zero Gate Voltage Drain Current	laaa	V _{DS} =	= 600 V, V _C	_{as} = 0 V	-	-	1	
Forward Transconductance ^a g_{fs} $V_{DS} = 8$ V, $l_p = 3$ A - 5.4 - S Dynamic Input Capacitance C_{6ss} $V_{DS} = 100$ V, $V_{DS} = 0$ V to 480 V, $V_{GS} = 0$ V - 2600 - - 138 - - 5.4 - S Beverse Transfer Capacitance C_{oss} $V_{GS} = 0$ V, $V_{DS} = 100$ V, $V_{DS} = 0$ V - 3 - - 38 - - 7.3 - - 98 - - 364 - - 346 - - 346 - - 346 - - 346 - - 346 - - 363 - - 346 - - 363 - - 363 - - 363 - - 363 - - 363 - - 10 - 10 - 10 - 10 - 10 - 10 - 10 - 10 - - 10	Zero date voltage Drain ourrent	USS	$V_{DS} = 600 V_{DS}$	/, V _{GS} = 0 '	V, T _J = 150 °C	-	-	100	μΛ
Dynamic Job Jo	Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I	l _D = 15 A	-	0.104	0.125	Ω
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance ^a	9 _{fs}	V _D	_S = 8 V, I _D	= 3 A	-	5.4	-	S
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Dynamic		•						•
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Input Capacitance	C _{iss}		$V_{co} = 0$	1	-	2600	-	
Reverse Transfer Capacitance C_{rss} $f = 1.0 \text{ MHz}$ $ 3$ $-$ Effective Output Capacitance, Energy Related a $C_{o(er)}$ $V_{DS} = 0 \text{ V}$ to $480 \text{ V}, V_{GS} = 0 \text{ V}$ $ 98$ $-$ Effective Output Capacitance, Time Related b $C_{o(tr)}$ $V_{DS} = 0 \text{ V}$ to $480 \text{ V}, V_{GS} = 0 \text{ V}$ $ 346$ $-$ Total Gate Charge Q_g Q_{gs} $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ $ 85$ 130 Gate-Drain Charge Q_{gd} $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ $ 15$ $-$ Turn-On Delay Time $t_{d(on)}$ $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ $ 19$ 40 Rise Time t_r $V_{QS} = 10 \text{ V}, R_g = 4.7 \Omega$ $ 63$ 95 $-$ Turn-Off Delay Time $t_d(off)$ $V_{GS} = 10 \text{ V}, R_g = 4.7 \Omega$ $ 63$ 95 $-$ Fall Time t_r T_g $f = 1 \text{ MHz}, open drain 0.63 \OmegaDrain-Source Body Diode CharacteristicsP^rP^r n junction diode 29APulsed Diode Forward CurrentI_SMOSFET symbol showing the integral reverse p - n junction diode 65-Diode Forward VoltageV_{SD}T_J = 25 °C, I_S = 15 \text{ A}, V_{GS} = 0 \text{ V} 1.3 \text{ V}Body Diode Reverse Recovery Timet_{rr}T_J = 25 °C, I_F = I_S = 15 \text{ A}, dI/dt = 100 A/\mus, V_R$	Output Capacitance					-	138	-	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Reverse Transfer Capacitance	C _{rss}		f = 1.0 MH	Ηz	-	3	-	
Effective Output Capacitance, Time Related b $C_{o(tr)}$ -346-Total Gate Charge Q_g Gate-Source Charge Q_{gd} Gate-Drain Charge Q_{gd} Tum-On Delay Time $t_{d(on)}$ Rise Time t_r Tum-Off Delay Time $t_{d(off)}$ Fall Time t_r Gate Input Resistance R_g f = 1 MHz, open drain-0.63-Optimular Source Body Diode CharacteristicsContinuous Source-Drain Diode Current I_S Num-Source Body Diode CharacteristicsContinuous Source-Drain Diode Current I_S Diode Forward Voltage V_{SD} Tug = 25 °C, I_S = 15 A, V_GS = 0 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C, I_F = I_S = 15 A, dI/dt = 100 A/µs, V_R = 20 V-Tug = 25 °C,	Effective Output Capacitance, Energy Related ^a					-	98	-	pF
Gate-Source Charge Q_{gs} $V_{GS} = 10 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 480 \text{ V}$ -15-nCGate-Drain Charge Q_{gd} Turn-On Delay Time $t_{d(on)}$ Rise Time t_r Turn-Off Delay Time $t_{d(off)}$ Fall Time t_r Fall Time t_f Gate Input Resistance R_g $r = 1 \text{ MHz}, open drain$ - 0.63 - 0.64 - 0.64 - 0.65 - 0.65 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - 0.665 - <td>Effective Output Capacitance, Time Related ^b</td> <td>C_{o(tr)}</td> <td>$V_{\rm DS} = 0$ V</td> <td>7 to 480 V,</td> <td>V_{GS} = 0 V</td> <td>-</td> <td>346</td> <td>-</td> <td></td>	Effective Output Capacitance, Time Related ^b	C _{o(tr)}	$V_{\rm DS} = 0$ V	7 to 480 V,	V _{GS} = 0 V	-	346	-	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Total Gate Charge	Qq				-	85	130	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	I _D = 15	A, V _{DS} = 480 V	-	15	-	nC
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Drain Charge	Q _{qd}				-	39	-	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time					-	19	40	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time			- 380 \/ I-	_ 15 A	-	32	65	
Fall Time t_f -3675Gate Input Resistance R_g $f = 1 \text{ MHz}$, open drain-0.63- Ω Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode Current I_S MOSFET symbol showing the integral reverse $p - n$ junction diode29APulsed Diode Forward Current I_{SM} $T_J = 25 ^{\circ}C$, $I_S = 15 \text{ A}$, $V_{GS} = 0 \text{ V}$ 1.3VBody Diode Reverse Recovery Time t_{rr} $T_J = 25 ^{\circ}C$, $I_F = I_S = 15 \text{ A}$, dl/dt = 100 A/µs, $V_R = 20 \text{ V}$ -71.5µC	Turn-Off Delay Time	t _{d(off)}	V _{DD} =	= 10 V, R _a	= 13 A, = 4.7 Ω	-	63	95	ns
Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse $p - n$ junction diode29APulsed Diode Forward CurrentIsmIsmTJ = 25 °C, Is = 15 A, Vgs = 0 V65-Diode Forward VoltageVspTJ = 25 °C, Is = 15 A, Vgs = 0 V1.3VBody Diode Reverse Recovery TimetrrTJ = 25 °C, IF = Is = 15 A, 	Fall Time			. 9		-	36	75	V/°(V/ μA μA Ω S nC nS Ω Λ
Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse p - n junction diode-29APulsed Diode Forward CurrentIsMIsM $T_J = 25 ^{\circ}C$, Is = 15 A, VGS = 0 V65ADiode Forward VoltageVSD $T_J = 25 ^{\circ}C$, Is = 15 A, VGS = 0 V1.3VBody Diode Reverse Recovery Time t_{rr} $T_J = 25 ^{\circ}C$, IF = IS = 15 A, dI/dt = 100 A/µs, VR = 20 V-715µC	Gate Input Resistance	R _q	f = 1	MHz, ope	n drain	-	0.63	-	Ω
Continuous Source-Drain Diode CurrentIsMOSFET symbol showing the integral reverse p - n junction diode-29APulsed Diode Forward CurrentIsMIsM $T_J = 25 \ ^{\circ}C$, Is = 15 A, VGS = 0 V65Diode Forward VoltageVsD $T_J = 25 \ ^{\circ}C$, Is = 15 A, VGS = 0 V1.3VBody Diode Reverse Recovery Time t_{rr} $T_J = 25 \ ^{\circ}C$, IF = IS = 15 A, dI/dt = 100 A/µs, VR = 20 V71.5µC	Drain-Source Body Diode Characteristic	÷	•						
Pulsed Diode Forward CurrentIsmIntegral reverse p - n junction diode65Diode Forward Voltage V_{SD} $T_J = 25 \ ^{\circ}C$, $I_S = 15 \ ^{\circ}A$, $V_{GS} = 0 \ ^{\circ}V$ 1.3 V Body Diode Reverse Recovery Time t_{rr} $T_J = 25 \ ^{\circ}C$, $I_F = I_S = 15 \ ^{\circ}A$, dl/dt = 100 A/µs, $V_R = 20 \ ^{\circ}V$ 402605nsDiode Reverse Recovery Charge Q_{rr} $T_J = 25 \ ^{\circ}C$, $I_F = I_S = 15 \ ^{\circ}A$, dl/dt = 100 A/µs, $V_R = 20 \ ^{\circ}V$ -715 μC	Continuous Source-Drain Diode Current	I _S	-	bol		-	-	29	
Body Diode Reverse Recovery Time t_{rr} $T_J = 25 \ ^\circ C$, $I_F = I_S = 15 \ A$, $dl/dt = 100 \ A/\mu s$, $V_R = 20 \ V$ $ 402$ 605 ns R_{rr} $T_J = 25 \ ^\circ C$, $I_F = I_S = 15 \ A$, $dl/dt = 100 \ A/\mu s$, $V_R = 20 \ V$ $ 7$ 15 μC	Pulsed Diode Forward Current	I _{SM}	integral revers			-	-	65	A
Body Diode Reverse Recovery Time t_{rr} $T_J = 25 \degree C, I_F = I_S = 15 \mbox{ A}, dl/dt = 100 \mbox{ A/}\mu s, V_R = 20 \mbox{ V}$ -402605nsT_J = 25 \degree C, I_F = I_S = 15 \mbox{ A}, dl/dt = 100 \mbox{ A/}\mu s, V_R = 20 \mbox{ V}-715 μC	Diode Forward Voltage	V _{SD}	T _J = 25 °0	C, I _S = 15 /	A, V _{GS} = 0 V	-	-	1.3	V
Body Diode Reverse Recovery Charge Q_{rr} $T_J = 25 \ ^{\circ}C, I_F = I_S = 15 \ A, dI/dt = 100 \ A/\mu s, V_R = 20 \ V$ -715 μC	Body Diode Reverse Recovery Time			-		-	402	605	ns
	, ,					-			μC
	Reverse Recovery Current	I _{RRM}	ai/at =	του A/μs,	$v_{\rm R} = 20 V$	-	32	65	A

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while $V_{\rm DS}$ is rising from 0 % to 80 % $V_{\rm DSS}.$

b. Coss(tr) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 % to 80 % VDSS.



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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

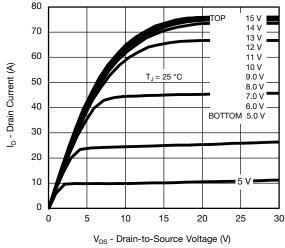
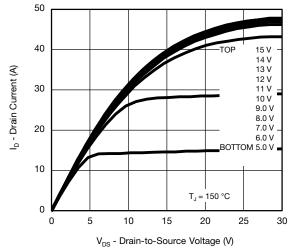
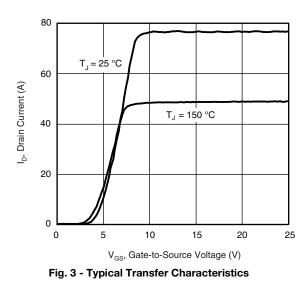


Fig. 1 - Typical Output Characteristics, T_C = 25 °C







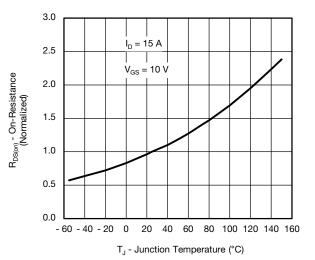


Fig. 4 - Normalized On-Resistance vs. Temperature

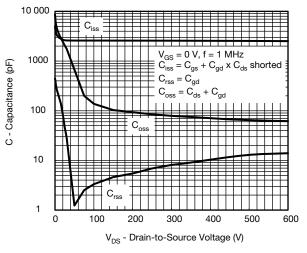
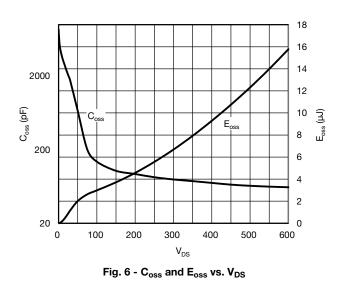


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



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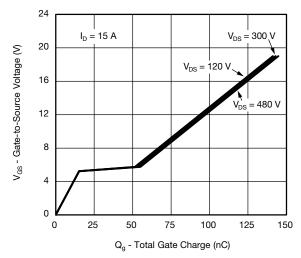
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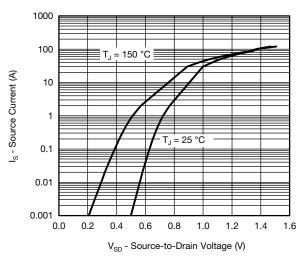
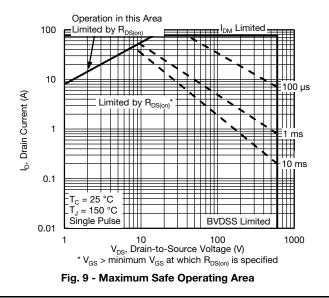


Fig. 8 - Typical Source-Drain Diode Forward Voltage



(3) 20.0 (3) 20.0 (5)

30.0

Fig. 10 - Maximum Drain Current vs. Case Temperature

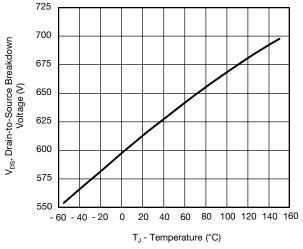


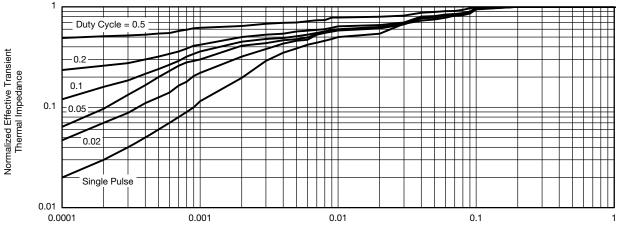
Fig. 11 - Temperature vs. Drain-to-Source Voltage

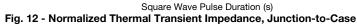
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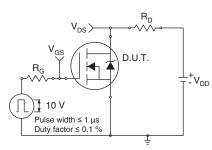


Fig. 13 - Switching Time Test Circuit

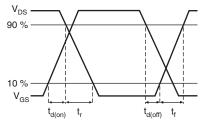


Fig. 14 - Switching Time Waveforms

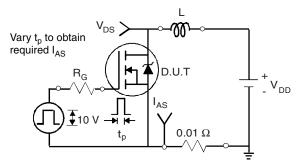


Fig. 15 - Unclamped Inductive Test Circuit

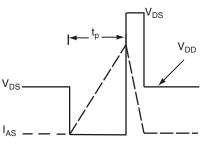


Fig. 16 - Unclamped Inductive Waveforms

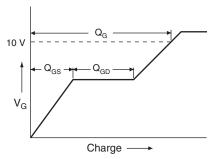
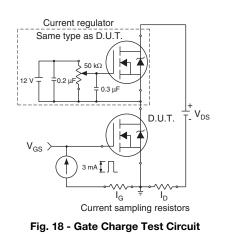


Fig. 17 - Basic Gate Charge Waveform



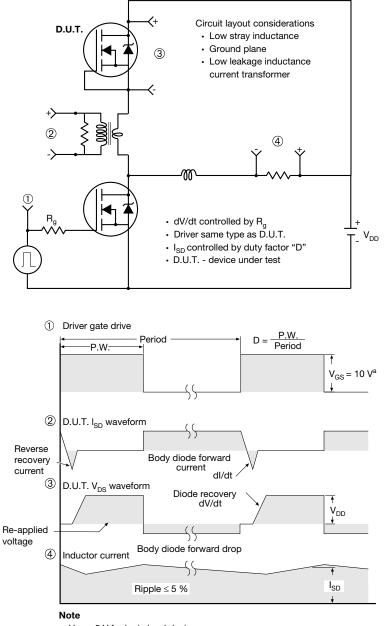
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Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5 V$ for logic level devices

Fig. 19 - For N-Channel

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Vishay Siliconix

TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9



		MILLIMETERS	
DIM.	MIN.	NOM.	MAX.
A	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

Notes

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
 6. Facility code will be the 1st character located at the 2nd row of the unit marking

1



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OPTION 2: FACILITY CODE = Y



	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100) BSC	
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

DWG: 5972

Notes

1. To be used only for process drawing

2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads

3. All critical dimensions should C meet $C_{pk} > 1.33$

4. All dimensions include burrs and plating thickness

5. No chipping or package damage
6. Facility code will be the 1st character located at the 2nd row of the unit marking

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Document Number: 91359

For technical questions, contact: hvmos.techsupport@vishay.com

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